## Application/Control No. Applicant(s)/Patent Under Reexamination 10/768,884 UEDA, HITOSHI Notice of References Cited Examiner Art Unit Page 1 of 1 2622 Tuan H. Le

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,519,692	05-1985	Michalik, John K.	396/48
*	В	US-2003/0197795	10-2003	Schinner, Charles E.	348/255
*	С	US-2003/0016301	01-2003	Aizaki et al.	348/345
*	D	US-5,196,938	03-1993	Blessinger, Kurt V.	348/22
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0			•		
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
į	U	
	٧	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.